FAIRCHILD

FDD5N50NZ N-Channel MOSFET 500V, 4A, 1.5Ω

Features

- $R_{DS(on)} = 1.38\Omega$ (Typ.)@ $V_{GS} = 10V$, $I_D = 2A$
- Low Gate Charge (Typ. 9nC)
- Low C_{rss} (Typ. 4pF)
- Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- ESD Imoroved Capability
- RoHS Compliant

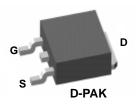


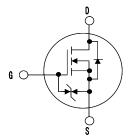


efficient switching mode power supplies and active power factor correction.

Description

stripe, DMOS technology.





These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar

This advance technology has been especially tailored to minimize on-state resistance, provide superior switching

performance, and withstand high energy pulse in the avalanche

and commutation mode. These devices are well suited for high

MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

Symbol		FDD5N50NZ	Units		
V _{DSS}	Drain to Source Voltage			500	V
V _{GSS}	Gate to Source Voltage		±25	V	
I _D	Drain Current	-Continuous ($T_C = 25^{\circ}C$)		4	^
	Drain Current	-Continuous (T _C = 100 ^o C)		2.4	A
I _{DM}	Drain Current	- Pulsed (Note 1)		16	А
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		(Note 2)	304	mJ
I _{AR}	Avalanche Current		(Note 1)	4	A
E _{AR}	Repetitive Avalanche Energy		(Note 1)	6.2	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	10	V/ns
P _D	Dower Dissignation	$(T_{C} = 25^{\circ}C)$		62	W
	Power Dissipation	- Derate above 25°C		0.5	W/ºC
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C
Τ _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C
*Drain current lir	nited by maximum junction temperature				

Thermal Characteristics

Symbol	Parameter	FDD5N50NZ	Units	
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	2.0 °C/W		
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	90		

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Device Marking FDD5N50NZ		Device	Package	PackageReel SizeD-PAK380mm		Tape Width 16mm		Quantity		
		FDD5N50NZTM	D-PAK					2500		
Electrica	I Char	racteristics T _c =	25ºC unless oth	nerwise noted						
Symbol		Parameter		Test Condition	IS	Min.	Тур.	Max.	Units	
Off Charac	teristic	S	· · · ·							
BV _{DSS}	Drain to	o Source Breakdown Vo	ltage I	$I_D = 250 \mu A$, $V_{GS} = 0V$, $T_J = 25^{\circ}C$			-	-	V	
ΔBV _{DSS} ΔTJ	Breakdown Voltage Temperature		ro	$I_D = 250\mu$ A, Referenced to 25° C		-	0.5	-	V/ºC	
	Zara C			$V_{DS} = 500V, V_{GS} = 0V$		-	-	1		
I _{DSS} Zero G		Bate Voltage Drain Current		$V_{DS} = 400V, T_{C} = 125^{\circ}C$		-	-	10	μA	
I _{GSS}	Gate to Body Leakage Current			$G_{GS} = \pm 25 V, V_{DS} = 0 V$		-	-	±10	μΑ	
On Charac	teristic	S								
V _{GS(th)}	Gate T	hreshold Voltage	١	/ _{GS} = V _{DS} , I _D = 250μA		3.0	-	5.0	V	
R _{DS(on)}		Drain to Source On Res		$V_{GS} = 10V, I_D = 2A$		-	1.38	1.5	Ω	
9 _{FS}	Forwar	d Transconductance		$V_{\rm DS} = 20V, I_{\rm D} = 2A$	(Note 4)	-	3.54	-	S	
C _{iss} C _{oss}	Output	apacitance Capacitance e Transfer Capacitance		V _{DS} = 25V, V _{GS} = 0V = 1MHz	-	-	330 50 4	440 70 6	pF pF	
C _{rss}		e Transfer Capacitance ate Charge at 10V		$V_{DS} = 400 V I_D = 4A$ $V_{GS} = 10 V$		-	4 9	6 12	pF nC	
Q _{g(tot)} Q _{gs}		Source Gate Charge	\			-	2	-	nC	
		Drain "Miller" Charge					4		nC	
Q _{gd}	Gale IO	Dialiti Miller Charge			(Note 4, 5)	-	4	-	nc	
Switching	Charac	teristics								
t _{d(on)}		n Delay Time				-	12	35	ns	
t _r		n Rise Time		$V_{DD} = 250V, I_D = 4A$ $V_{GS} = 10V, R_G = 25\Omega$		-	22	55	ns	
t _{d(off)}		ff Delay Time				-	28	65	ns	
t _f	Turn-O	ff Fall Time			(Note 4, 5)	-	21	50	ns	
Drain-Sou		de Characteristics						1		
l _S	Maximum Continuous Drain to Source Diode Forward Current				-	-	4	Α		
I _{SM}		Maximum Pulsed Drain to Source Diode Forward Current			-	-	16	A		
V _{SD}		Source Diode Forward	0	$I_{GS} = 0V, I_{SD} = 4A$		-	-	1.4	V	
t _{rr}		e Recovery Time		$I_{GS} = 0V, I_{SD} = 4A$	-	-	315	-	ns	
Q _{rr}	Reverse	e Recovery Charge	d	I _F /dt = 100A/μs	(Note 4)	-	1.8	-	μC	

Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature

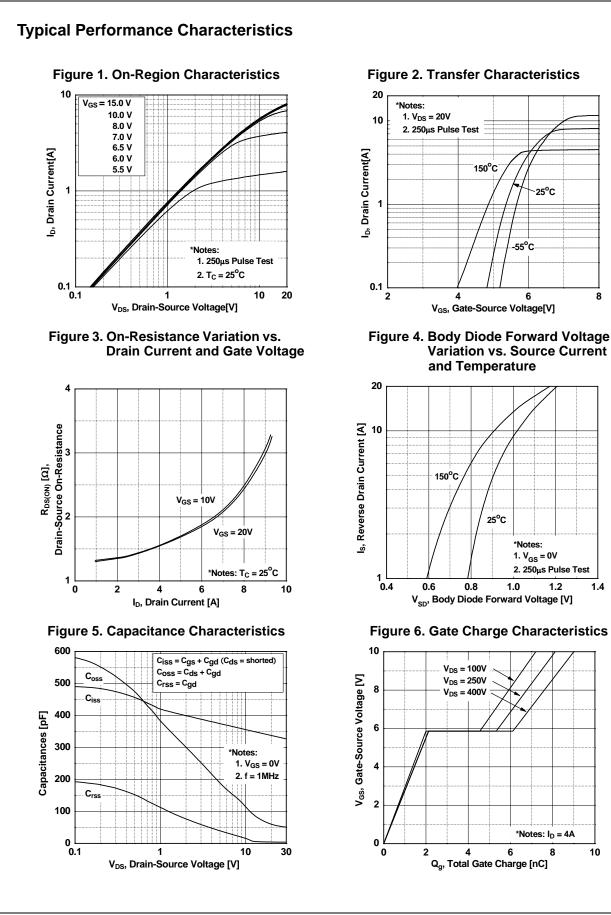
2. L = 38mH, I_{AS} = 4A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C

3. $I_{SD} \leq 4A, \, di/dt \leq 200A/\mu s, \, V_{DD} \leq BV_{DSS}, \, Starting \, T_J$ = $25^{\circ}C$

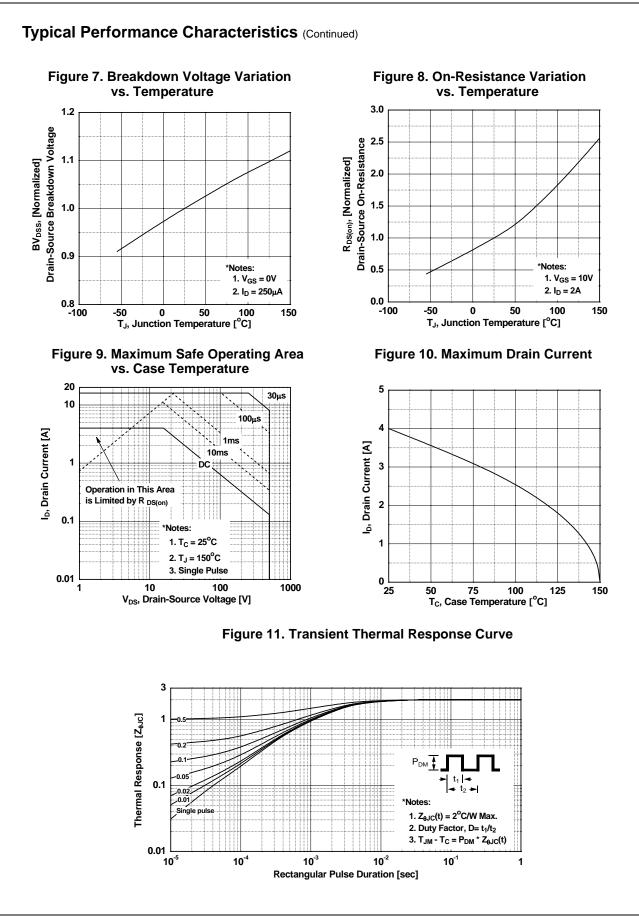
4. Pulse Test: Pulse width $\leq 300 \mu s,$ Dual Cycle $\leq 2\%$

5. Essentially Independent of Operating Temperature Typical Characteristics

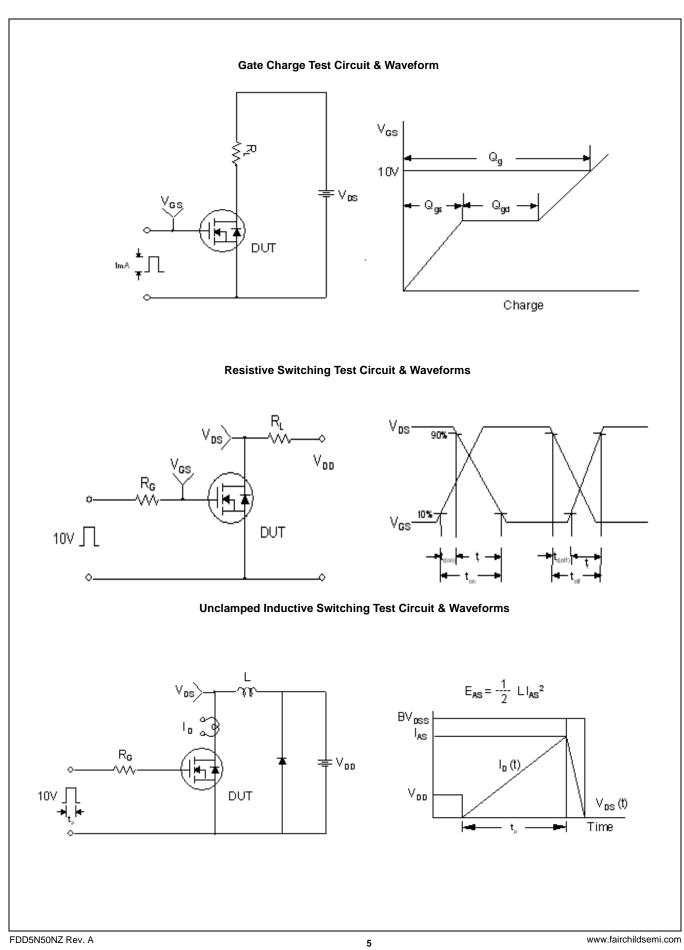
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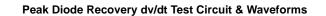


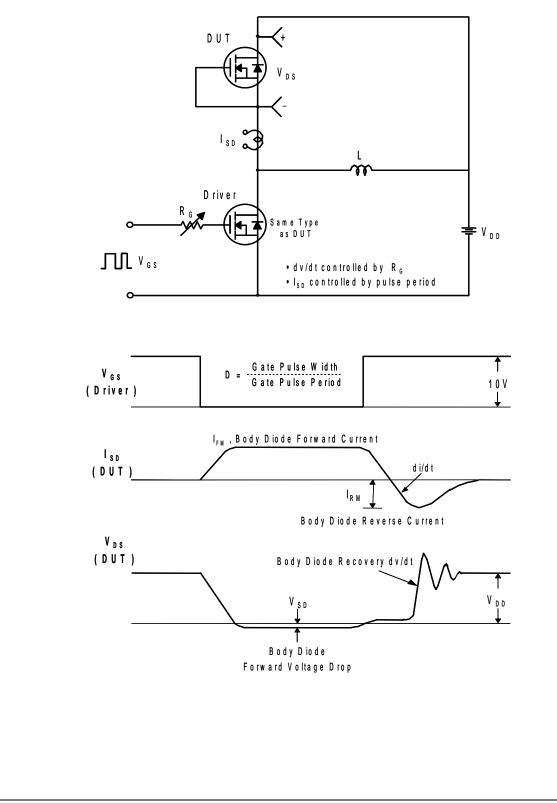
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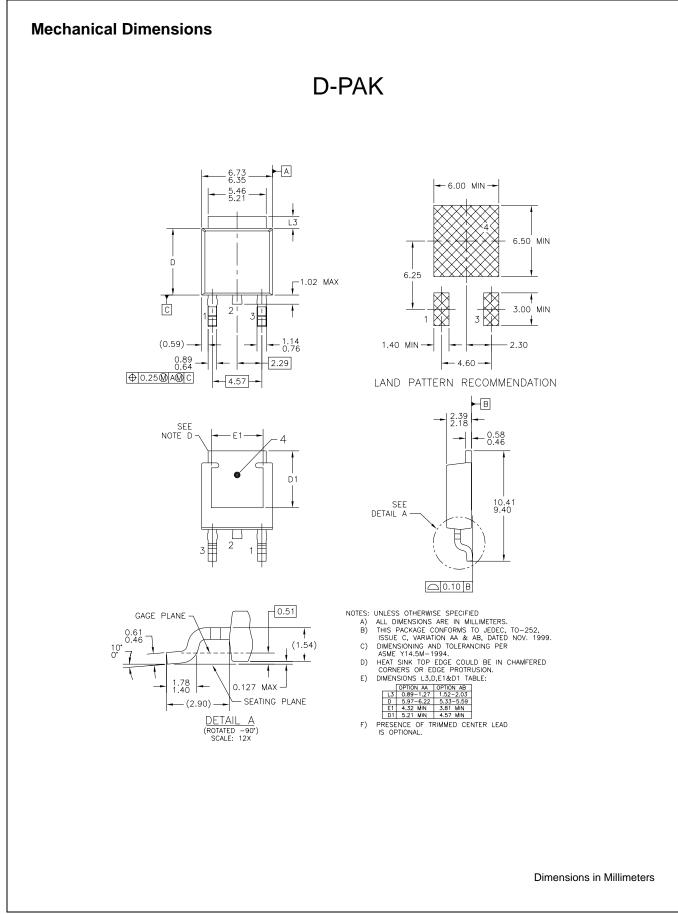


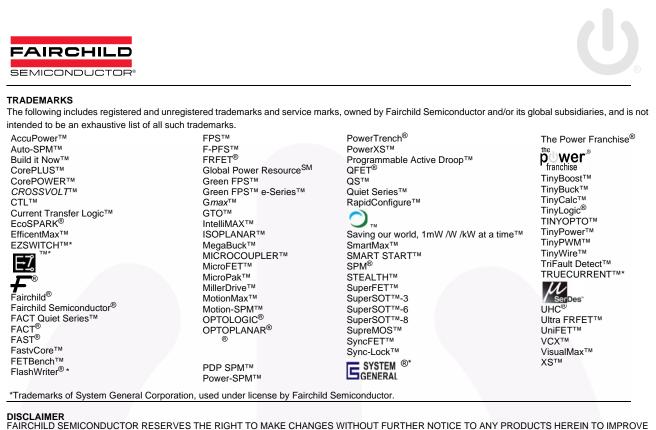
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